Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/560,494	SCHREY ET AL.	
Examiner	Art Unit	
Patrick J. Lee	2878	

SEARCHED					
Class	Subclass	Date	Examiner		
250	214.1, 214R, 208.1	5/0/07 5/1/06 6/1/07	PL		
. 348	294, 392	V	PL		
Updated	search	9/19/2007	PL		
4					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			(0)	
	ice search ched	9/19/2007	PL	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	5/10/2007	PL		
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	5/21/2007	PL		
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	6/19/2007	·PL		
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	6/20/2007	PL		
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	9/19/2007	PL		
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